


Form PTO-1449 COMMERCE (REV. 7-80)		U.S. DEPARTMENT OF PATENT AND TRADEMARK OFFICE		Atty. Docket No. NL 010061		Serial No. 10/067,429								
				Applicant FREDERIK VISSER ET AL.										
				Filing Date 2/4/02		Group <del>2862</del> 2859								
<b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)														
<b>U.S. PATENT DOCUMENTS</b>														
Ex. Int.		Document Number							Date	Name	Class	Sub-class	Filing Date If Applicable	
IAF	AA	5	1	6	0	8	9	1	11/3/92	KEREN	324	318		
IAF	AB	5	3	9	9	9	7	0	3/21/95	PELE ET AL.	324	309		
	AC													
	AD													
	AE													
	AF													
<b>FOREIGN PATENT DOCUMENTS</b>														
		Document Number							Date	Country	Class	Sub-class	Trans.	
													Yes	No
IAF	AG	0	4	7	2	3	9	0 A 2	26/2/92	EUROPE	G01R	33/54		
	AH													
	AI													
	AJ													
	AK													
<b>OTHER (Including Author, Title, Date, Pertinent Pages, Etc.)</b>														
IAF	AL	Sodickson et al., "SMAH Imaging," Magnetic Resonance Imaging, vol. 7, no. 2, May 1999, pages 237-254												
	AM													
	AN													
Examiner <i>Tiffany A. Fagan</i>										Date Considered <i>April 24<sup>th</sup> 2003</i>				
<b>*EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.														

Form PTO-1449  
(REV. 8-83)

US Dept. of Commerce  
PATENT & TRADEMARK OFFICE

ATTY DOCKET NO.  
112192

APPLICATION NO.  
10/167,429

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS  
Fumio NOMIZO et al.

FILING DATE  
June 14, 2002



U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

RECEIVED  
JUL 22 2002  
TC 1700

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
<del>JP-U-63-156421</del>	<del>10/13/1988</del>	<del>Japan</del>		

No  
Translation

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)


EXAMINER

*Tiffany A. Fegner*

DATE CONSIDERED

*April 24<sup>th</sup> 2003*

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: July 18, 2002